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- Controlled Baseline
 One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of -40°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product Change Notification
- Qualification Pedigree[†]
- Buffered Inputs
- Common 3-State Output-Enable Control
- 3-State Outputs
- Bus-Line Driving Capability
- Typical Propagation Delay (Clock to Q): 15 ns at V_{CC} = 5 V, C_L = 15 pF, T_A = 25°C
 - Fanout (Over Temperature Range)
 - Standard Outputs ... 10 LSTTL Loads
 - Bus Driver Outputs ... 15 LSTTL Loads
- [†] Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

description/ordering information

- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- V_{CC} Voltage = 4.5 V to 5.5 V
- Direct LSTTL Input Logic Compatibility, V_{IL} = 0.8 V (Max), V_{IH} = 2 V (Min)
- CMOS Input Compatibility, II \leq 1 μA at V_OL, V_OH

M OR PW PACKAGE (TOP VIEW)									
OE [D0 [D1 [D2 [D3 [D4 [D5 [D6 [D7 [1 2 3 4 5 6 7 8 9	J	20 19 18 17 16 15 14 13 12] V _{CC}] Q0] Q1] Q2] Q3] Q4] Q5] Q6] Q7					
GND [10)	11	СР					

The CD74HCT574 is an octal D-type flip-flop with 3-state outputs and the capability to drive 15 LSTTL loads. The eight edge-triggered flip-flops enter data into their registers on the low-to-high transition of the clock (CP). The output enable (\overline{OE}) controls the 3-state outputs and is independent of the register operation. When \overline{OE} is high, the outputs are in the high-impedance state.

T _A	PACK	AGE [‡]	ORDERABLE PART NUMBER	TOP-SIDE MARKING								
4000 10 40500	SOIC – M	Tape and reel	CD74HCT574QM96EP	HCT574EP								
–40°C to 125°C	TSSOP – PW	Tape and reel	CD74HCT574QPWREP	HCT574EP								

ORDERING INFORMATION

[‡] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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FUNCTION TABLE

	INPUTS		OUTPUT
OE	СР	D	Q
L	\uparrow	Н	Н
L	\uparrow	L	L
L	L	Х	Q ₀
Н	Х	Х	Z

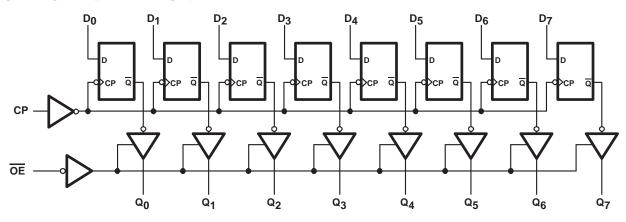
NOTE: H = High voltage level (steady state)

L = Low voltage level (steady state) X = Don't care

 \uparrow = Transition from low to high level Q_0 = Level before the indicated steady-state conditions were established

Z = High-impedance state

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} (see Note 1) -0.5 V to 7 V Input clamp current, I _{IK} (V _I < -0.5 V or V _I > V _{CC} + 0.5 V) $\pm 20 \text{ mA}$ Output clamp current, I _{OK} (V _O < -0.5 V or V _O > V _{CC} + 0.5 V) $\pm 20 \text{ mA}$
Drain current per output, I_O ($V_O > -0.5$ V or $V_O < V_{CC} + 0.5$ V) ±35 mA
Output source or sink current per output, $I_O (V_O > -0.5 \text{ V or } V_O < V_{CC} + 0.5 \text{ V}) \dots \pm 25 \text{ mA}$
Continuous current through V _{CC} or GND, I _{CC} ±50 mA
Package thermal impedance, θ _{JA} (see Note 2): M package
PW package
Maximum junction temperature, T _J 150°C Lead temperature (during soldering):
At distance $1/16 \pm 1/32$ inch $(1,59 \pm 0,79 \text{ mm})$ from case for 10 s max
Storage temperature range, T _{stg}

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages referenced to GND unless otherwise specified.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	V
VIH	High-level input voltage $V_{CC} = 4.5 \text{ V to } 5.5$	V 2		V
VIL	Low-level input voltage $V_{CC} = 4.5 \text{ V to } 5.5$	V	0.8	V
VI	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
	$V_{CC} = 2 V$	0	1000	
^t t	Input transition (rise and fall) time $V_{CC} = 4.5 V$	0	500	
	V _{CC} = 6 V	0	400	
Τ _Α	Operating free-air temperature	-40	125	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	I _O (mA)	Vcc	т,	₄ = 25°C	;	T _A = - TO 12	UNIT			
			(mA)		MIN	TYP	MAX	MIN	MAX		
N		CMOS loads	-0.02	4.5 V	4.4			4.4		V	
VOH	$V_I = V_{IH} \text{ or } V_{IL}$	TTL loads	-6	4.5 V	3.98			3.7		V	
		CMOS loads	0.02	4.5 V			0.1		0.1		
VOL	$V_{I} = V_{IH} \text{ or } V_{IL}$	TTL loads	6	4.5 V			0.26		0.4	V	
lj	$V_I = V_{CC}$ or GND		0	5.5 V			±0.1		±1	μA	
I _{OZ}	$V_I = V_{IL} \text{ or } V_{IH},$	$V_{O} = V_{CC} \text{ or } GND$		6 V			±0.5		±10	μA	
Icc	$V_I = V_{CC}$ or GND		0	5.5 V			8		160	μA	
ΔICC	$V_{I} = V_{CC} - 2.1 V,$	See Note 4		4.5 V to 5.5 V		100	360		490	μA	
C _{IN}	C _L = 50 pF						10		10	pF	
COUT	3-state						20		20	pF	

NOTE 4: For dual-supply systems, theoretical worst-case (VI = 2.4 V, V_{CC} = 5.5 V) specification is 1.8 mA.

HCT input loading

INPUT	UNIT LOADS [†]
D0-D7	0.4
CP	0.75
OE	0.6
	D0–D7 CP

[†]Unit load is ΔI_{CC} limit specified in electrical characteristics table, e.g., 360 µA max at 25°C.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

	PARAMETER	Vcc	T _A = 2	25°C	T _A = - TO 12	UNIT	
			MIN	MAX	MIN	MAX	
fmax	Maximum clock frequency	4.5 V	30		20		MHz
tw	Clock pulse duration	4.5 V	16		24		ns
t _{su}	Setup time, data before clock↑	4.5 V	12		18		ns
th	Hold time, data after clock↑	4.5 V	5		5		ns



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switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO	LOAD CAPACITANCE	vcc	Т	λ = 25°C	;	T _A = - TO 12		UNIT	
	(INPUT)	(OUTPUT)	CAPACITANCE		MIN	TYP	MAX	MIN	MAX		
	t _{pd} CP	0	CL = 50 pF	4.5 V			33		50		
^t pd		Q	CL = 15 pF	5 V		15				ns	
4	OE	0	CL = 50 pF	4.5 V			28		42		
^t dis	OE	Q	CL = 15 pF	5 V		11				ns	
	OE	0	C _L = 50 pF	4.5 V			30		45		
ten	OE	Q	CL = 15 pF	5 V		12				ns	
tt		Q	C _L = 50 pF	4.5 V			12		18	ns	
f _{max}	СР		C _L = 15 pF	5 V		60				MHz	

operating characteristics, V_{CC} = 5 V, T_A = 25°C, input t_r , t_f = 6 ns

	PARAMETER	TYP	UNIT
Cpd	Power dissipation capacitance (see Note 5)	47	pF
NOTE	F_{1} C is used to determine the dynamic neuron consumption (P-), per peckage		

NOTE 5: C_{pd} is used to determine the dynamic power consumption (P_D), per package.

 $P_{D}^{P_{D}} = (C_{PD} \times V_{CC}^{2} \times f_{I}) + \Sigma (C_{L} \times V_{CC}^{2} \times f_{O})$

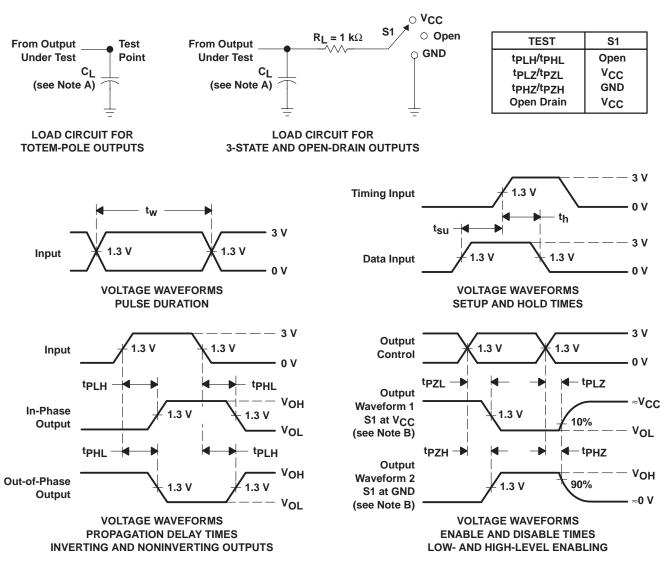
f_I = input frequency

 f_O = output frequency C_L = output load capacitance

 V_{CC} = supply voltage



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r \leq 6 ns, t_f \leq 6 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.
- F. tpLH and tpHL are the same as tpd.
- G. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- H. tPZH and tPZL are the same as ten.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD74HCT574QM96EP	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74HCT574QPWREP	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
V62/04739-01XE	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
V62/04739-01YE	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF CD74HCT574-EP :

- Catalog: CD74HCT574
- Automotive: CD74HCT574-Q1
- Military: CD54HCT574

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications

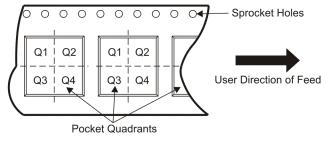
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

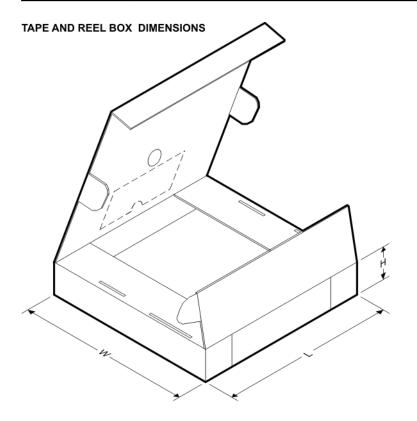


*All dimensions are nominal												
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HCT574QM96EP	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74HCT574QPWREP	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1



PACKAGE MATERIALS INFORMATION

5-Aug-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HCT574QM96EP	SOIC	DW	20	2000	346.0	346.0	41.0
CD74HCT574QPWREP	TSSOP	PW	20	2000	346.0	346.0	33.0

MECHANICAL DATA

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



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